

---

---

## Analogue quartz clocks — Timing accuracy

*Horloges analogiques à quartz — Précision du temps*

STANDARDSISO.COM : Click to view the full PDF of ISO 19235:2015



STANDARDSISO.COM : Click to view the full PDF of ISO 19235:2015



**COPYRIGHT PROTECTED DOCUMENT**

© ISO 2015, Published in Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized otherwise in any form or by any means, electronic or mechanical, including photocopying, or posting on the internet or an intranet, without prior written permission. Permission can be requested from either ISO at the address below or ISO's member body in the country of the requester.

ISO copyright office  
Ch. de Blandonnet 8 • CP 401  
CH-1214 Vernier, Geneva, Switzerland  
Tel. +41 22 749 01 11  
Fax +41 22 749 09 47  
copyright@iso.org  
www.iso.org

# Contents

|                                                                                 | Page     |
|---------------------------------------------------------------------------------|----------|
| Foreword .....                                                                  | iv       |
| Introduction .....                                                              | v        |
| <b>1 Scope .....</b>                                                            | <b>1</b> |
| <b>2 Terms and definitions .....</b>                                            | <b>1</b> |
| <b>3 Basic parameters and requirements of timing accuracy .....</b>             | <b>1</b> |
| 3.1 Mean instantaneous rate .....                                               | 1        |
| 3.2 Voltage coefficient, $C_U$ .....                                            | 1        |
| 3.3 Temperature coefficient, $C_t$ .....                                        | 2        |
| <b>4 Test methods .....</b>                                                     | <b>2</b> |
| 4.1 Test conditions .....                                                       | 2        |
| 4.1.1 Test environment .....                                                    | 2        |
| 4.1.2 Power supply .....                                                        | 2        |
| 4.1.3 Pre-running .....                                                         | 2        |
| 4.2 Test apparatus .....                                                        | 2        |
| 4.3 Testing .....                                                               | 2        |
| 4.3.1 Mean instantaneous rate .....                                             | 2        |
| 4.3.2 Voltage coefficient, $C_U$ .....                                          | 3        |
| 4.3.3 Temperature coefficient, $C_t$ .....                                      | 3        |
| <b>Annex A (informative) Main factors affecting the timing accuracy .....</b>   | <b>5</b> |
| <b>Annex B (informative) Timing accuracy expressions of quartz clocks .....</b> | <b>6</b> |
| <b>Bibliography .....</b>                                                       | <b>7</b> |

## Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see [www.iso.org/directives](http://www.iso.org/directives)).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see [www.iso.org/patents](http://www.iso.org/patents)).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation on the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the WTO principles in the Technical Barriers to Trade (TBT) see the following URL: [Foreword - Supplementary information](#)

The committee responsible for this document is ISO/TC 114, *Horology*, Subcommittee SC 14, *Table and wall clocks*.

## Introduction

Each year, there is a large number of analogue quartz clocks produced and this International Standard aims to provide quality information for consumers and producers. This International Standard will help producers by giving them quality control methods and customers by informing them about expectations they could have on those products.

STANDARDSISO.COM : Click to view the full PDF of ISO 19235:2015

STANDARDSISO.COM : Click to view the full PDF of ISO 19235:2015

# Analogue quartz clocks — Timing accuracy

## 1 Scope

This International Standard specifies the basic parameters, requirements, and testing methods of timing accuracy for analogue quartz clocks, hereinafter referred to as “the quartz clock”.

This International Standard applies to analogue quartz table and wall clocks which the oscillator frequency is 32 768 Hz and the nominal voltage is DC 1,5 V. Analogue quartz clock movements can refer to it.

This International Standard does not apply to the following quartz clocks:

- clocks for particular applications such as clocks used in aircraft, ship, vehicle, and facilities;
- clocks incorporated into other products;
- clocks in which time is radio-synchronized.

## 2 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

### 2.1

#### mean instantaneous rate

$\bar{m}$

arithmetic mean value of three instantaneous rates of the quartz clock separately measured on three successive days, in “s/d” or “s/m”

### 2.2

#### voltage coefficient

$C_U$

variation rate of instantaneous rate of the quartz clock caused by the variation of source voltage

### 2.3

#### temperature coefficient

$C_t$

variation rate of instantaneous rate of the quartz clock caused by the variation of temperature

### 2.4

#### nominal voltage

$U_n$

voltage for which the movement is destined

## 3 Basic parameters and requirements of timing accuracy

### 3.1 Mean instantaneous rate, $\bar{m}$

After the quartz clock has been continuously running for 3 d, the mean instantaneous rate shall be within  $-1,0$  s/d to  $+1,0$  s/d.

### 3.2 Voltage coefficient, $C_U$

The voltage coefficient,  $C_U$ , shall be within  $-1,0$  s/(d·V) to  $+1,0$  s/(d·V).

### 3.3 Temperature coefficient, $C_t$

The temperature coefficient,  $C_{t1}$ , shall be within 0 s/(d·°C) to +0,1 s/(d·°C) and  $C_{t2}$  shall be within -0,1 s/(d·°C) to 0 s/(d·°C).

## 4 Test methods

### 4.1 Test conditions

#### 4.1.1 Test environment

The test ambient temperature shall be 18 °C to 25 °C, the temperature variation shall be within  $\pm 2$  °C during the whole test and the relative humidity shall be between 50 % and 70 %.

#### 4.1.2 Power supply

Unless otherwise specified, the test power supply during the test shall be the nominal voltage of the quartz clock of DC 1,5 V.

#### 4.1.3 Pre-running

Before the test, the quartz clock shall run for at least 2 h in the test environment specified in 4.1.1.

### 4.2 Test apparatus

The resolution and maximum permissible error of the test apparatus can refer to Table 1.

**Table 1 — Test apparatus**

| Test apparatus                     | Resolution   | Maximum permissible error |
|------------------------------------|--------------|---------------------------|
| Instantaneous rate test instrument | 0,01 s/d     | $\pm 0,03$ s/d            |
| Temperature and humidity cabinet   | 1 °C, RH 1 % | $\pm 1$ °C, RH $\pm 5$ %  |
| Constant voltage power supply      | 0,01 V       | $\pm 0,5$ %               |

### 4.3 Testing

#### 4.3.1 Mean instantaneous rate, $\bar{m}$

The quartz clock shall be placed at a temperature of  $(23 \pm 1)$  °C for at least 2 h. Then the instantaneous rates  $m_1$ ,  $m_2$ ,  $m_3$  for the first, second and third day shall be measured respectively and the mean instantaneous rate  $\bar{m}$  calculated in accordance with Formula (1):

$$\bar{m} = \frac{m_1 + m_2 + m_3}{3} \quad (1)$$

where

$\bar{m}$  is the mean instantaneous rate for 3 d;

$m_1$  is the instantaneous rate of the first day;

$m_2$  is the instantaneous rate of the second day;

$m_3$  is the instantaneous rate of the third day.

#### 4.3.2 Voltage coefficient, $C_U$

The instantaneous rate variation of the quartz clock caused by 1 V voltage variation is called the voltage coefficient,  $C_U$ , when the supply voltage of the quartz clock is reduced from 100 %  $U_n$  to 90 %  $U_n$ .

The instantaneous rates of the quartz clock  $m_{1,50}$  and  $m_{1,35}$  shall be measured respectively under the supply voltage of DC 1,50 V and DC 1,35 V, when  $U_n$  is 1,50 V, and  $C_U$  is calculated in accordance with Formula (2):

$$C_U = \frac{m_{1,50} - m_{1,35}}{1,50 - 1,35} \quad (2)$$

where

$C_U$  is the voltage coefficient, in s/(d·V);

$m_{1,50}$  is the instantaneous rate under the voltage of DC 1,50 V (100 %), in s/d;

$m_{1,35}$  is the instantaneous rate under the voltage of DC 1,35 V (90 %  $U_n$ ), in s/d.

#### 4.3.3 Temperature coefficient, $C_t$

The variation of instantaneous rate caused by 1 °C temperature variation is called temperature coefficient,  $C_{t1}$ , when the temperature is decreased from 23 °C to 8 °C. The variation of instantaneous rate caused by 1 °C temperature variation is called temperature coefficient,  $C_{t2}$ , when the temperature is increased from 23 °C to 38 °C.

The quartz clock shall be placed at a temperature of 23 °C ± 1 °C for at least 2 h, then the instantaneous rate,  $m_{23}$ , shall be measured. Afterwards, it shall be placed at a temperature of 8 °C ± 1 °C for at least 2 h, then the instantaneous rate,  $m_8$ , shall be measured. After the test, it shall be placed for 1 h in the environment described in 4.1.1 and then placed at a temperature of 38 °C ± 1 °C for at least 2 h. Afterwards, the instantaneous rate,  $m_{38}$ , shall be measured.  $C_{t1}$  and  $C_{t2}$  are calculated in accordance with Formula (3) and Formula (4), respectively:

$$C_{t1} = \frac{m_{23} - m_8}{23 - 8} \quad (3)$$

where

$C_{t1}$  is the temperature coefficient when the temperature is decreased from 23 °C to 8 °C, in s/(d·°C);

$m_{23}$  is the instantaneous rate at 23 °C, in s/d;

$m_8$  is the instantaneous rate at 8 °C, in s/d.

$$C_{t2} = \frac{m_{38} - m_{23}}{38 - 23} \quad (4)$$

where

$C_{t2}$  is the temperature coefficient when the temperature is increased from 23 °C to 38 °C, in s/(d·°C);

$m_{23}$  is the instantaneous rate at 23 °C, in s/d;

$m_{38}$  is the instantaneous rate at 38 °C, in s/d.

STANDARDSISO.COM : Click to view the full PDF of ISO 19235:2015

## **Annex A**

### **(informative)**

## **Main factors affecting the timing accuracy**

### **A.1 General**

The main factors affecting the timing accuracy of the quartz clocks are temperature and ageing.

### **A.2 Temperature**

The quartz crystal frequency and the load capacitance value inside the oscillation circuit of the quartz clock change along with the temperature. This change will have impact on the timing accuracy of the quartz clock. The timing accuracy of the quartz clock at the low or high temperature is different from the timing accuracy at the test environment temperature of  $(23 \pm 1) ^\circ\text{C}$ . The instantaneous rate shall be within  $-2,0 \text{ s/d}$  to  $+1,0 \text{ s/d}$  in the temperature range of  $8 ^\circ\text{C}$  to  $38 ^\circ\text{C}$ .

### **A.3 Ageing**

The main ageing factors for quartz clock include the following:

- ageing of the quartz;
- ageing of the load capacitance inside the oscillation circuit;
- decrease of the vacuum encapsulation of quartz.

The ageing factors will have certain impacts on timing accuracy of the quartz clock. Usually, after the quartz clock has been used in normal condition ( $10 ^\circ\text{C}$  to  $35 ^\circ\text{C}$ ,  $\text{RH} \leq 70 \%$ ) for 1 y, it may cause  $\pm 0,2 \text{ s/d}$  variation in mean instantaneous rate. Consumers should be aware of this ageing impact on timing accuracy after the quartz clock has been regularly used over 1 y.